

## **Serial EEPROM Series Standard EEPROM**

## **WLCSP EEPROM**

# BU9889GUL-W (8Kbit)



#### General Description

BU9889GUL-W is a serial EEPROM of I<sup>2</sup>C BUS interface method.

#### Features

- Completely conforming to the world standard I<sup>2</sup>C BUS.
   All controls available by 2 ports of serial clock (SCL) and serial data (SDA)
- 1k words × 8 bits architecture 8kbit serial EEPROM.
- Other devices than EEPROM can be connected to the same port, saving microcontroller port.
- 1.7V to 5.5V single power source action most suitable for battery use.
- FAST MODE 400kHz at 1.7V to 5.5V
- Page write mode useful for initial value write at factory shipment.
- Auto erase and auto end function at data rewrite.
- Low current consumption

At write operation (5V) : 0.5mA (Typ.)
 At read operation (5V) : 0.2mA (Typ.)
 At standby operation (5V) : 0.1μA (Typ.)

- Write mistake prevention function
  - Write (write protect) function added
  - Write mistake prevention function at low voltage
- Data rewrite up to 100,000 times
- Data kept for 40 years
- Noise filter built in SCL / SDA terminal
- Shipment data all address FFh

◆Package W(Typ.) x D(Typ.) x H(Max.) VCSP50L1 1.60mm x 1.00mm x 0.55mm

#### ■Absolute Maximum Ratings (Ta=25°C)

Parameter	symbol	Limits	Unit	Remarks
Impressed voltage	V <sub>CC</sub>	-0.3 to +6.5	V	
Permissible dissipation	Pd	220	mW	When using at Ta=25°C or higher, 2.2mW to be reduced per 1°C
Storage temperature range	Tstg	-65 to +125	°C	
Action temperature range	Topr	-40 to +85	°C	
Terminal voltage	-	-0.3 to V <sub>CC</sub> +1.0	V	

#### ■Memory cell characteristics (Ta=25°C, Vcc=1.7V to 5.5V)

Parameter		Limits			
Farameter	Min.	Тур.	Max.	Unit	
Number of data rewrite times *1	100,000	-	-	Times	
Data hold years *1	40	-	-	Years	
Shipment data all address FFh					

<sup>\*1</sup> Not 100% TESTED

#### Recommended Operating Ratings

Parameter	Symbol	Limits	Unit
Power source voltage	V <sub>CC</sub>	1.7 to 5.5	V
Input voltage	V <sub>IN</sub>	0 to V <sub>CC</sub>	V

● Electrical Characteristics (Unless otherwise specified Ta=-40°C to +85°C, Vcc=1.7V to 5.5V)

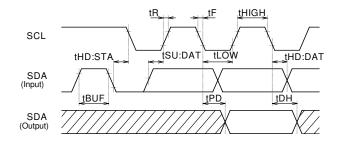
Parameter	Symbol		Limits		Unit	Condition
Farameter	Symbol	Min	Тур.	Max.	Offic	Condition
"H" Input Voltage1	VIH1	0.7V <sub>CC</sub>	-	V <sub>CC</sub> +1.0	V	
"L" Input Voltage1	VIL1	-0.3	-	0.3V <sub>CC</sub>	V	
"L" Output Voltage1	VOL1	-	-	0.4	V	IoL=3.0mA , 2.5V≦V <sub>CC</sub> ≦5.5V (SDA)
"L" Output Voltage2	VOL2	-	-	0.2	٧	IoL=0.7mA , 1.7V≦V <sub>CC</sub> ≦2.5V (SDA)
Input Leakage Current	lu	-1	-	1	μA	VIN=0 to V <sub>CC</sub>
Output Leakage Current	llo	-1	-	1	μA	VOUT=0 to V <sub>CC</sub> (SDA)
Current consumption at action	ICC1	-	-	2.0	mA	V <sub>CC</sub> =5.5V, fSCL =400kHz, tWR=5ms Byte Write, Page Write
Current consumption at action	ICC2	-	-	0.5	mA	V <sub>CC</sub> =5.5V, fSCL =400kHz Random read, Current read, Sequential read
Standby Current	ISB	-	-	2.0	μA	V <sub>CC</sub> =5.5V, SDA • SCL=V <sub>CC</sub> A2=GND, WP=GND

● Action timing characteristics (Unless otherwise specified Ta=-40°C to +85°C, Vcc=1.7V to 5.5V)

Davamatav	Currele el	Limits			1.154	
Parameter	Symbol	Min.	. Тур. Мах.		Unit	
SCL Frequency	fSCL	-	-	400	kHz	
Data clock "High" time	tHIGH	0.6	-	-	μs	
Data clock "Low" time	tLOW	1.2	-	-	μs	
SDA, SCL rise time *1	tR	-	-	0.3	μs	
SDA, SCL fall time *1	tF	-	-	0.3	μs	
Start condition hold time	tHD:STA	0.6	-	-	μs	
Start condition setup time	tSU:STA	0.6	-	-	μs	
Input data hold time	tHD:DAT	0	-	-	ns	
Input data setup time	tSU:DAT	100	-	-	ns	
Output data delay time	tPD	0.1	-	0.9	μs	
Output data hold time	tDH	0.1	-	-	μs	
Stop condition data setup time	tSU:STO	0.6	-	-	μs	
Bus release time before transfer start	tBUF	1.2	-	-	μs	
Internal write cycle time	tWR	-	-	5	ms	
Noise removal valid period (SDA,SCL terminal)	tl	-	-	0.1	μs	
WP hold time	tHD:WP	0	-	-	ns	
WP setup time	tSU:WP	0.1	-	-	μs	
WP valid time	tHIGH:WP	1.0	-	-	μs	

<sup>\*1 :</sup> Not 100% TESTED

#### ●Sync Data Input / Output Timing



Olnput read at the rise edge of SCL OData output in sync with the fall of SCL

Figure 1-(a) Sync data input / output timing

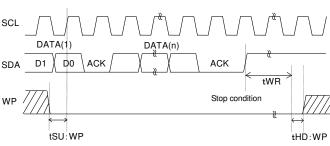


Figure 1-(d) WP timing at write execution

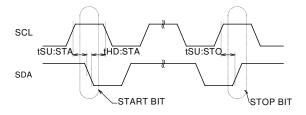
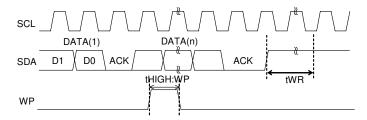


Figure 1-(b) Start - stop bit timing



OAt write execution, in the area from the D0 taken clock rise of the first DATA(1), to tWR, set WP= 'LOW'.

OBy setting WP "HIGH" in the area, write can be cancelled.

When it is set WP = 'HIGH' during tWR, write is forcibly ended, and data of address under access is not guaranteed, therefore write it once again.

Figure 1-(e) WP timing at write cancel

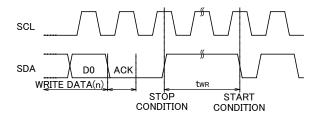
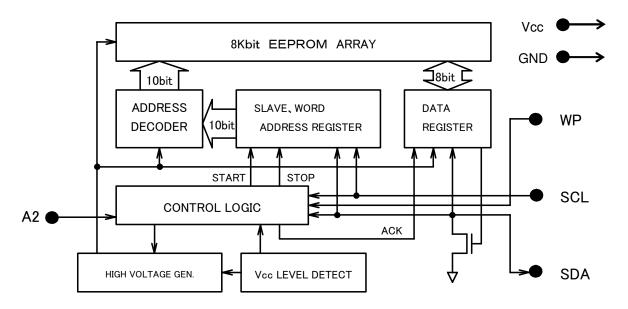
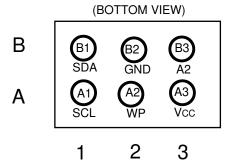


Figure 1-(c) Write cycle timing

## ● Block Diagram



## ●Pin Configuration



## ●Pin Descriptions

Terminal name	Input/ Output	Function
A2	Input	Slave address setting
GND	-	Reference voltage of all input / output, 0V.
SDA	Input / Output	Slave and word address, Serial data input serial data output
SCL	Input	Serial clock input
WP	Input	Write protect terminal
Vcc	-	Connect the power source.

## **●**Typical Performance Curves

(The following values are Typ. ones.)

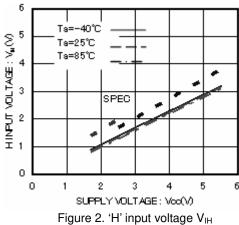


Figure 2. 'H' input voltage  $V_{\text{IH}}$  (A2, SCL, SDA, WP)

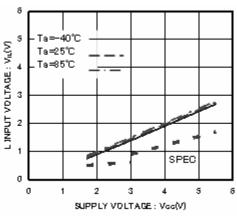
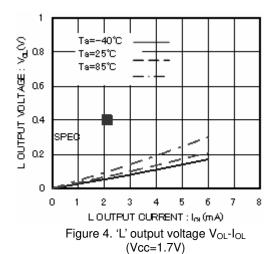


Figure 3. 'L' input voltage  $V_{IL}$  (A2, SCL, SDA, WP)



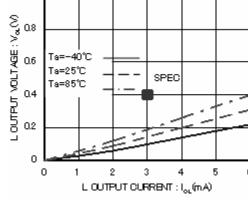
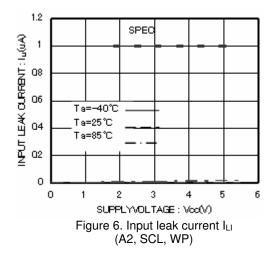


Figure 5. 'L' output voltage  $V_{OL}$ - $I_{OL}$  (Vcc=2.5V)



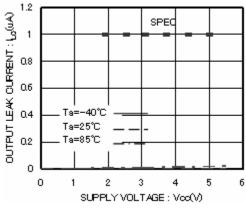


Figure 7. Output leak current I<sub>L0</sub>(SDA)

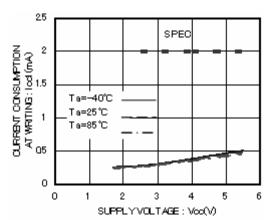


Figure 8. Current consumption at WRITE operation I<sub>CC</sub>1 (fscl=400kHz)

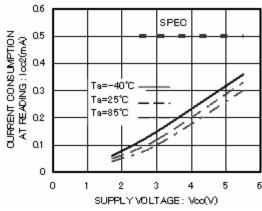
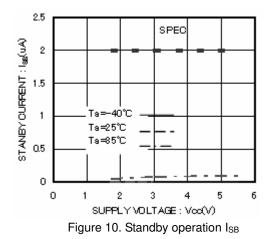
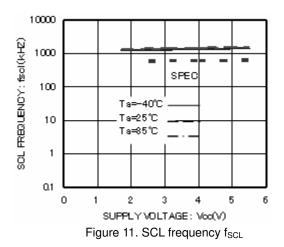
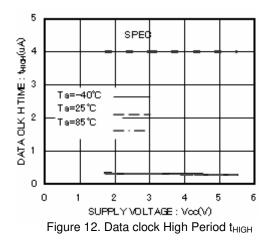


Figure 9. Current consumption at READ operation I<sub>CC</sub>2 (fscl=400kHz)







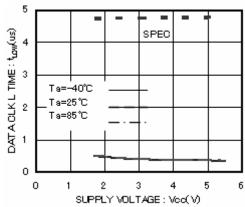


Figure 13. Data clock Low Period t<sub>LOW</sub>

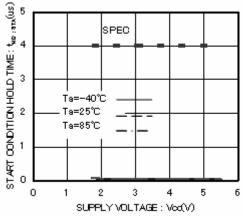


Figure 14. Start Condition Hold Time tho:STA

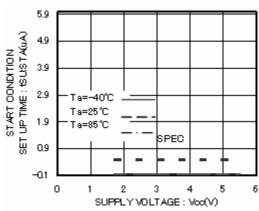
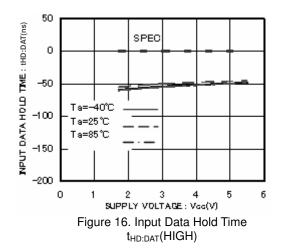
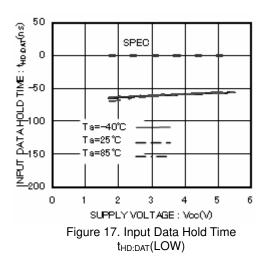
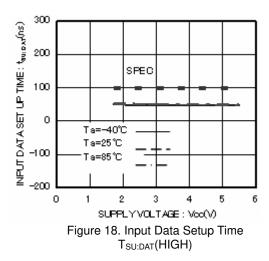
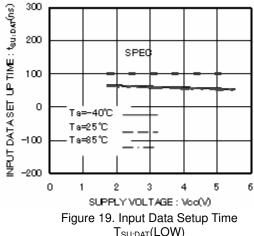


Figure 15. Start Condition Setup Time t<sub>SU:STA</sub>

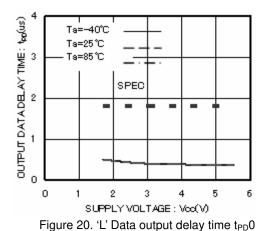








T<sub>SU:DAT</sub>(LOW)



OUTPUT DATA DELAY TIME : \$p(us) Ta=-40°C Ta=25°C 3 Ta=85°C SPEC 2 2 3 SUPPLY VOLTAGE: Vcc(V)

Figure 21. 'H' Data output delay time tPD1

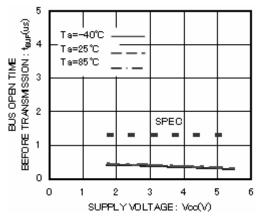


Figure 22. BUS open time before transmission  $t_{\text{BUF}}$ 

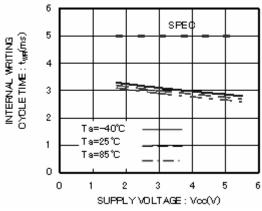


Figure 23. Internal writing cycle time twR

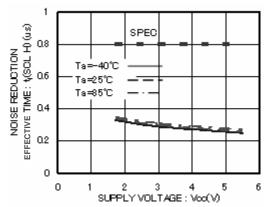


Figure 24. Noise reduction effective time t1 (SCL H)

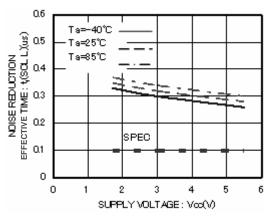


Figure 25. Noise reduction effective time t<sub>I</sub>(SCL L)

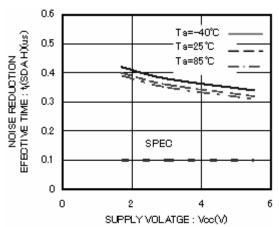


Figure 26. Noise reduction effective time t<sub>I</sub> (SDAH)

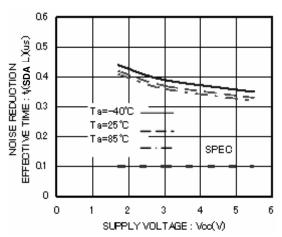
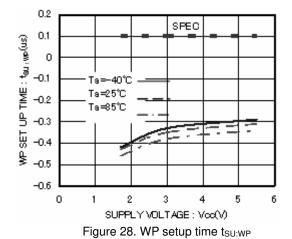
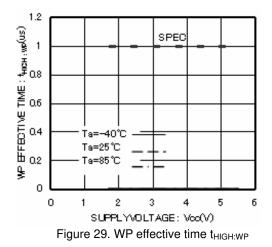


Figure 27. Noise reduction effective time t<sub>I</sub>(SDA L)





#### ●I<sup>2</sup>C BUS communication

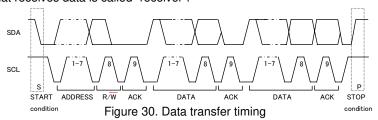
#### Ol<sup>2</sup>C BUS data communication

I<sup>2</sup>C BUS data communication starts by start condition input, and ends by stop condition input. Data is always 8bit long, and acknowledge is always required after each byte.

I<sup>2</sup>C BUS carries out data transmission with plural devices connected by 2 communication lines of serial data (SDA) and serial clock (SCL).

Among devices, there are "master" that generates clock and control communication start and end, and "slave" that is controlled by addresses peculiar to devices.

EEPROM becomes "slave". And the device that outputs data to bus during data communication is called "transmitter", and the device that receives data is called "receiver".



#### OStart condition (start bit recognition)

- Before executing each command, start condition (start bit) where SDA goes from 'HIGH' down to 'LOW' when SCL is 'HIGH' is necessary.
- This IC always detects whether SDA and SCL are in start condition (start bit) or not, therefore, unless this condition is satisfied, any command is executed.

#### OStop condition (stop bit recognition)

• Each command can be ended by SDA rising from 'LOW' to 'HIGH' when stop condition (stop bit), namely, SCL is 'HIGH'

#### OAcknowledge (ACK) signal

- This acknowledge (ACK) signal is a software rule to show whether data transfer has been made normally or not. In master and slave, the device (µ-COM at slave address input of write command, read command, and this IC at data output of read command) at the transmitter (sending) side releases the bus after output of 8bit data.
- The device (this IC at slave address input of write command, read command, and μ-COM at data output of read command) at the receiver (receiving) side sets SDA 'LOW' during 9 clock cycles, and outputs acknowledge signal (ACK signal) showing that it has received the 8bit data.
- This IC, after recognizing start condition and slave address (8bit), outputs acknowledge signal (ACK signal) 'LOW'.
- Each write action outputs acknowledge signal) (ACK signal) 'LOW', at receiving 8bit data (word address and write data).
- · Each read action outputs 8bit data (read data), and detects acknowledge signal (ACK signal) 'LOW'.
- When acknowledge signal (ACK signal) is detected, and stop condition is not sent from the master (µ-COM) side, this IC continues data output. When acknowledge signal (ACK signal) is not detected, this IC stops data transfer, and recognizes stop condition (stop bit), and ends read action. And this IC gets in standby status.

#### ODevice addressing

- Following a START condition, the master output the slave address to be accessed.
- The most significant four bits of the slave address are the "device type indentifier," for this device it is fixed as "1010".
- The next bit (device address) identify the specified device on the bus. The device address is defined by the state of A2 input pin. This IC works only when the device address inputted from SDA pin correspond to the state of A2 input pin. Using this address scheme, up to two devices may be connected to the bus.
- The next two bits (P1, P0) are used by the master to select four 256 word page of memory.

P1, P0 set to "0" "0"  $\cdots$  1page (000 to 0FF)

P1, P0 set to "0" "1" · · · 1page (100 to 1FF)

P1, P0 set to "1" "0" · · · 1page (200 to 2FF)

P1, P0 set to "1" "1" · · · 1page (300 to 3FF)

• The last bit of the stream (R/W ··· READ/WRITE) determines the operation to be performed. When set to "1", a read operation is selected; when set to "0", a write operation is selected.

 $R\overline{/W}$  set to "0"  $\cdots$  WRITE (including word address input of Random Read) R/W set to "1"  $\cdots$  READ

1 0 1 0 A2 P1 P0 R/W
----------------------

#### Write Command

OWrite cycle

• Arbitrary data is written to EEPROM. When to write only 1 byte, byte write normally used, and when to write continuous data of 2 bytes or more, simultaneous write is possible by page write cycle.

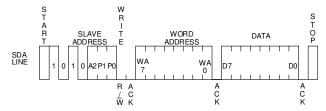


Figure 31. Byte write cycle

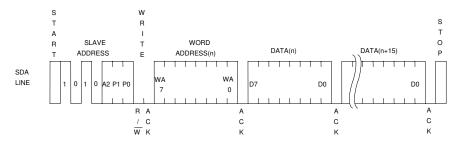


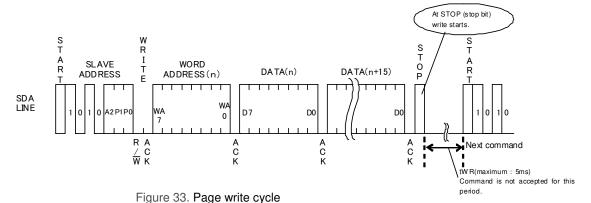
Figure 32. Page write cycle

- Data is written to the address designated by word address (n-th address).
- By issuing stop bit after 8bit data input, write to memory cell inside starts.
- · When internal write is started, command is not accepted for tWR (5ms at maximum).
- By page write cycle, the following can be written in bulk: Up to 16 bytes

  And when data of the maximum bytes or higher is sent, data from the first byte is overwritten.

  (Refer to "Internal address increment" in Pape14.)
- As for page write command, after page select bit(PS) of slave address is designated arbitrarily, by continuing data input of 2 bytes or more, the address of insignificant 4 bits is incremented internally, and data up to 16 bytes can be written.

#### ONotes on write cycle continuous input



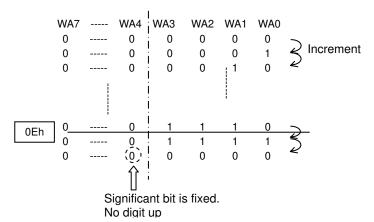
#### ONotes on page write cycle

Maximum page number is 16 bytes for this IC. Any bytes below these can be written.

The page write cycle write time is 5ms at maximum for 16byte bulk write. It does not stand 5ms at maximum  $\times$  16byte = 80ms(Max.).

#### OInternal address increment

Page write mode



For example, when it is started from address 0Eh, therefore, increment is made as below,  $0Eh\rightarrow 0Fh\rightarrow 00h\rightarrow 01h\cdots$ , which please note.

#### OWrite protect (WP) terminal

· Write protect (WP) function

When WP terminal is set Vcc (H level), data rewrite of all address is prohibited. When it is set GND (L level), data rewrite of all address is enabled. Be sure to connect this terminal to Vcc or GND, or control it to H level or L level. Do not use it open. At extremely low voltage at power ON/OFF, by setting the WP terminal 'H', mistake write can be prevented. During tWR, set the WP terminal always to 'L'. If it is set 'H', write is forcibly terminated.

 $<sup>^{\</sup>star}$  0Eh···16 in hexadecimal, therefore, 00001110 becomes a binary number.

#### Read Command

#### ORead cycle

Data of EEPROM is read. In read cycle, there are random read cycle and current read cycle.

Random read cycle is a command to read data by designating address, and is used generally.

Current read cycle is a command to read data of internal address register without designating address, and is used when to verify just after write cycle. In both the read cycles, sequential read cycle is available, and the next address data can be read in succession.

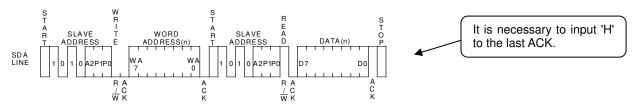


Figure 34. Random read cycle

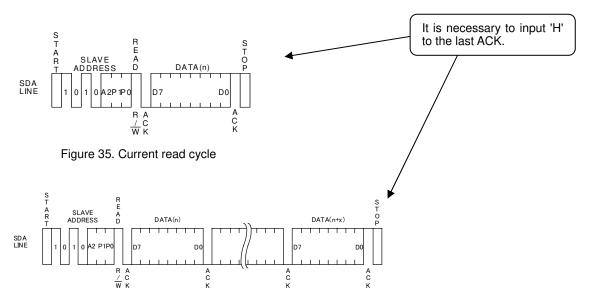


Figure 36. Sequential read cycle (in the case of current read cycle)

- In random read cycle, data of designated word address can be read.
- When the command just before current read cycle is random read cycle, current read cycle (each including sequential read cycle), data of incremented last read address (n)-th address, i.e., data of the (n+1)-th address is output.
- When ACK signal 'LOW' after D0 is detected, and stop condition is not sent from master (μ-COM) side, the next address data can be read in succession.
- · Read cycle is ended by stop condition where 'H' is input to ACK signal after D0 and SDA signal is started at SCL signal 'H'.
- When 'H' is not input to ACK signal after D0, sequential read gets in, and the next data is output.

  Therefore, read command cycle cannot be ended. When to end read command cycle, be sure input stop condition to input 'H' to ACK signal after D0, and to start SDA at SCL signal 'H'.
- Sequential read is ended by stop condition where 'H' is input to ACK signal after arbitrary D0 and SDA is started at SCL signal 'H'.

#### ●Software reset

Software reset is executed when to avoid malfunction after power on, and to reset during command input. Software reset has several kinds, and 3 kids of them are shown in the figure below. (Refer to Figure 37-(a), Figure 37-(b), Figure 37-(c).) In dummy clock input area, release the SDA bus ('H' by pull up). In dummy clock area, ACK output and read data '0' (both 'L' level) may be output from EEPROM, therefore, if 'H' is input forcibly, output may conflict and over current may flow, leading to instantaneous power failure of system power source or influence upon devices.

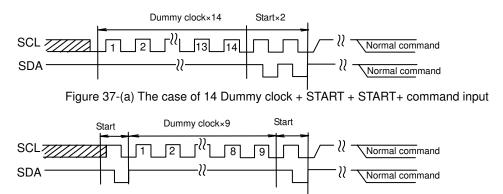


Figure 37-(b) The case of START+9 Dummy clock + START + command input

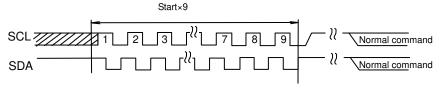


Figure 37-(c) START × 9 + command input

#### Acknowledge polling

During internal write, all input commands are ignored, therefore ACK is not sent back. During internal automatic write execution after write cycle input, next command (slave address) is sent, and if the first ACK signal sends back 'L', then it means end of write action, while if it sends back 'H', it means now in writing. By use of acknowledge polling, next command can be executed without waiting for tWR = 5ms.

When to write continuously,  $R/\overline{W}=0$ , when to carry out current read cycle after write, slave address  $R/\overline{W}=1$  is sent, and if ACK signal sends back 'L', then execute word address input and data so forth.

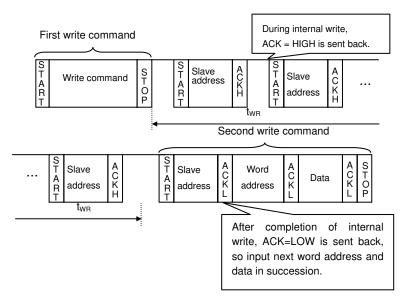


Figure 38. Case to continuously write by acknowledge polling

<sup>\*</sup> Start command from START input.

#### WP valid timing (write cancel)

WP is usually fixed to 'H' or 'L', but when WP is used to cancel write cycle and so forth, pay attention to the following WP valid timing. During write cycle execution, in cancel valid area, by setting WP='H', write cycle can be cancelled. In both byte write cycle and page write cycle, the area from the first start condition of command to the rise of clock to taken in D0 of data (in page write cycle, the first byte data) is cancel invalid area.

WP input in this area becomes Don't care. Set the setup time to rise of D0 taken 100ns or more. The area from the rise of SCL to take in D0 to the end of internal automatic write (tWR) is cancel valid area. And, when it is set WP='H' during tWR, write is ended forcibly, data of address under access is not guaranteed, therefore, write it once again.(Refer to Figure 39.) After execution of forced end by WP standby status gets in, so there is no need to wait for tWR (5ms at maximum).

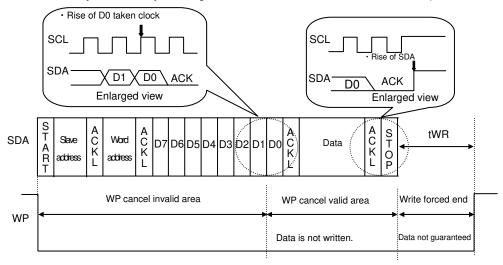


Figure 39. WP valid timing

## ●Command cancel by start condition and stop condition

During command input, by continuously inputting start condition and stop condition, command can be cancelled. (Refer to Figure 40.)

However, in ACK output area and during data read, SDA bus may output 'L', and in this case, start condition and stop condition cannot be input, so reset is not available. Therefore, execute software reset. And when command is cancelled by start, stop condition, during random read cycle, sequential read cycle, or current read cycle, internal setting address is not determined, therefore, it is not possible to carry out current read cycle in succession. When to carry out read cycle in succession, carry out random read cycle.

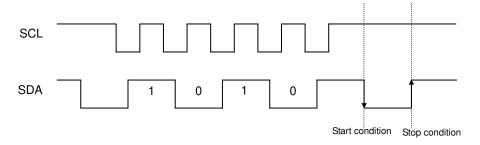


Figure 40. Case of cancel by start, stop condition during slave address input

#### ●I/O peripheral circuit

OPull up resistance of SDA terminal

SDA is NMOS open drain, so requires pull up resistance. As for this resistance value ( $R_{PU}$ ), select an appropriate value to this resistance value from microcontroller  $V_{IL}$ ,  $I_{L}$ , and  $V_{OL}$ - $I_{OL}$  characteristics of this IC. If  $R_{PU}$  is large, action frequency is limited. The smaller the  $R_{PU}$ , the larger the consumption current at action.

#### OMaximum value of RPU

The maximum value of R<sub>PU</sub> is determined by the following factors.

- (1)SDA rise time to be determined by the capacitance (CBUS) of bus line of R<sub>PU</sub> and SDA should be tR or below. And AC timing should be satisfied even when SDA rise time is late.
- (2)The bus electric potential @to be determined by input leak total (I<sub>L</sub>) of device connected to bus output of 'H' to SDA bus and R<sub>PU</sub> should sufficiently secure the input 'H' level (V<sub>IH</sub>) of microcontroller and EEPROM including recommended noise margin 0.2Vcc.

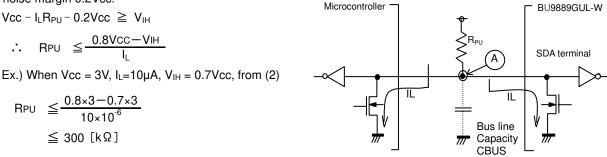


Figure 41. I/O circuit diagram

#### OMinimum value of RPU

The minimum value of R<sub>PU</sub> is determined by the following factors.

(1) When IC outputs LOW, it should be satisfied that V<sub>OLMAX</sub>=0.4V and I<sub>OLMAX</sub>=3mA.

$$\frac{\text{Vec} \quad \text{Vec}}{\text{RPU}} \leq \text{IOL}$$

$$\therefore \quad \text{RPU} \quad \geq \frac{\text{Vcc} - \text{Vol}}{\text{IOL}}$$

(2)V<sub>OLMAX</sub>=0.4V should secure the input 'L' level (V<sub>IL</sub>) of microcontroller and EEPROM including recommended noise margin 0.1Vcc.

$$V_{OLMAX} \leq V_{IL}$$
-0.1 Vcc

Ex.) When Vcc= 3V,  $V_{OL}0.4V$ ,  $I_{OL}=3mA$ , microcontroller, EEPROM  $V_{IL}=0.3Vcc$  from(1),

$$\begin{array}{ccc} \text{R}_{\text{PU}} & \geq \frac{3-0.4}{3\times 10^{-3}} \\ & \geq 867 \; [\Omega] \\ \\ \text{And} & & \text{V}_{\text{OL}} = 0.4 \; [\text{V}] \\ & & \text{V}_{\text{IL}} = 0.3\times 3 \\ & & = 0.9 \; [\text{V}] \\ \end{array}$$

Therefore, the condition (2) is satisfied.

#### OPull up resistance of SCL terminal

When SCL control is made at CMOS output port, there is no need, but in the case there is timing where SCL becomes 'Hi-Z', add a pull up resistance. As for the pull up resistance, one of several  $k\Omega$  to several ten  $k\Omega$  is recommended in consideration of drive performance of output port of microcontroller.

#### ● A2, WP process

OProcess of device address terminals (A2)

Check whether the set device address coincides with device address input sent from the master side or not, and select one among plural devices connected to a same bus. Connect this terminal to pull up or pull down, or Vcc or GND.

#### OProcess of WP terminal

WP terminal is the terminal that prohibits and permits write in hardware manner. In 'H' status, only READ is available and WRITE of all address is prohibited. In the case of 'L', both are available. In the case of use it as an ROM, it is recommended to connect it to pull up or Vcc. In the case to use both READ and WRITE, control WP terminal or connect it to pull down or GND.

#### Cautions on microcontroller connection

ORs

In I<sup>2</sup>C BUS, it is recommended that SDA port is of open drain input/output. However, when to use CMOS input / output of tri state to SDA port, insert a series resistance Rs between the pull up resistance Rpu and the SDA terminal of EEPROM. This is controls over current that occurs when PMOS of the microcontroller and NMOS of EEPROM are turned ON simultaneously. Rs also plays the role of protection of SDA terminal against surge. Therefore, even when SDA port is open drain input/output, Rs can be used.

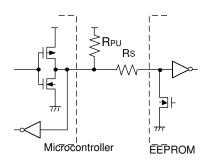
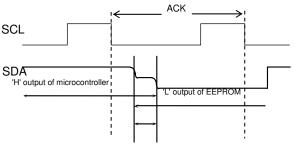


Figure 42. I/O circuit diagram



Over current flows to SDA line by 'H' output of microcontroller and 'L' output of EEPROM.

Figure 43. Input/output collision timing

#### OMaximum value of Rs

The maximum value of Rs is determined by following relations.

- (1)SDA rise time to be determined by the capacity (CBUS) of bus line of Rpu and SDA shoulder be tR or below. And AC timing should be satisfied even when SDA rise time is late.
- (2)The bus electric potential (2) to be determined by Rpu and Rs the moment when EEPROM outputs 'L' to SDA bus should sufficiently secure the input 'L' level (V<sub>IL</sub>) of microcontroller including recommended noise margin 0.1Vcc.

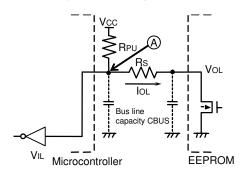


Figure 44. I/O circuit diagram

$$\therefore RS \leq \frac{VIL-VOL-0.1VCC}{1.1VCC-VIL} \times RPU$$

Example) When VCC=3V, VIL=0.3VCC, VOL=0.4V, RPU=20k  $\Omega\,,$ 

from(2), Rs 
$$\leq \frac{0.3 \times 3 - 0.4 - 0.1 \times 3}{1.1 \times 3 - 0.3 \times 3} \times 20 \times 10^{\circ}$$
  
 $\leq 1.67 [k\Omega]$ 

#### OMaximum value of Rs

The minimum value of Rs is determined by over current at bus collision. When over current flows, noises in power source line, and instantaneous power failure of power source may occur. When allowable over current is defined as I, the following relation must be satisfied. Determine the allowable current in consideration of impedance of power source line in set and so forth. Set the over current to EEPROM 10mA or below.

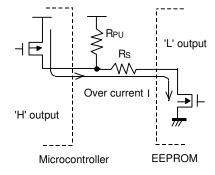


Figure 45. I/O circuit diagram

$$\frac{\text{VCC}}{\text{Rs}} \le I$$

$$\therefore \text{Rs} \ge \frac{\text{VCC}}{I}$$

Example) When VCC=3V, I=10mA

$$\operatorname{As} \geq \frac{3}{10 \times 10^{-3}}$$
$$\geq 300[\Omega]$$

#### ●I<sup>2</sup>C BUS input / output circuit

OInput (A2, SCL, WP)

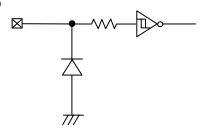


Figure 46. Input pin circuit diagram

#### OInput/Output (SDA)

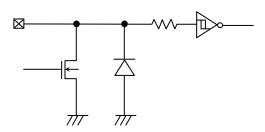
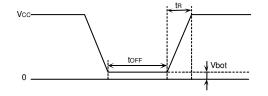


Figure 47. Input /output pin circuit diagram

#### Notes on power ON

At power on, in IC internal circuit and set, Vcc rises through unstable low voltage area, and IC inside is not completely reset, and malfunction may occur. To prevent this, functions of POR circuit and LVCC circuit are equipped. To assure the action, observe the following condition at power on.

- 1. Set SDA = 'H' and SCL ='L' or 'H'
- 2. Start power source so as to satisfy the recommended conditions of tR, tOFF, and Vbot for operating POR circuit.



Recommended conditions of tR, tOFF, Vbot

recommended conditions of the torre, voca					
tR	tOFF	Vbot			
10ms or below	10ms or longer	0.3V or below			
100ms or below	10ms or longer	0.2V or below			

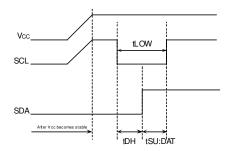
Figure 48. Rise waveform diagram

3. Set SDA and SCL so as not to become 'Hi-Z'.

When the above conditions 1 and 2 cannot be observed, take the following countermeasures.

a) In the case when the above conditions 1 cannot be observed. When SDA becomes 'L' at power on.

→Control SCL and SDA as shown below, to make SCL and SDA, 'H' and 'H'.



After Vice becomes stable

Figure 49. When SCL='H' and SDA='L'

Figure 50. When SCL='H' and SDA='L'

- b) In the case when the above condition 2 cannot be observed.
  - →After power source becomes stable, execute software reset(Page 16).
- c) In the case when the above conditions 1 and 2 cannot be observed.
  - →Carry out a), and then carry out b).

#### ●Low voltage malfunction prevention function

LVCC circuit prevents data rewrite action at low power, and prevents wrong write.

At LVCC voltage (Typ. =1.2V) or below, it prevent data rewrite.

#### Vcc noise countermeasures

OBypass capacitor

When noise or surge gets in the power source line, malfunction may occur, therefore, for removing these, it is recommended to attach a bypass capacitor ( $0.1\mu F$ ) between IC Vcc and GND. At that moment, attach it as close to IC as possible. And, it is also recommended to attach a bypass capacitor between board Vcc and GND.

#### Cautions on use

- (1)Described numeric values and data are design representative values, and the values are not guaranteed.
- (2)We believe that application circuit examples are recommendable, however, in actual use, confirm characteristics further sufficiently. In the case of use by changing the fixed number of external parts, make your decision with sufficient margin in consideration of static characteristics and transition characteristics and fluctuations of external parts and our LSI.
- (3) Absolute maximum ratings

If the absolute maximum ratings such as impressed voltage and action temperature range and so forth are exceeded, LSI may be destructed. Do not impress voltage and temperature exceeding the absolute maximum ratings. In the case of fear exceeding the absolute maximum ratings, take physical safety countermeasures such as fuses, and see to it that conditions exceeding the absolute maximum ratings should not be impressed to LSI.

(4)GND electric potential

Set the voltage of GND terminal lowest at any action condition. Make sure that each terminal voltage is lower than that of GND terminal.

(5)Terminal design

In consideration of permissible loss in actual use condition, carry out heat design with sufficient margin.

(6) Terminal to terminal shortcircuit and wrong packaging

When to package LSI onto a board, pay sufficient attention to LSI direction and displacement. Wrong packaging may destruct LSI. And in the case of shortcircuit between LSI terminals and terminals and power source, terminal and GND owing to foreign matter, LSI may be destructed.

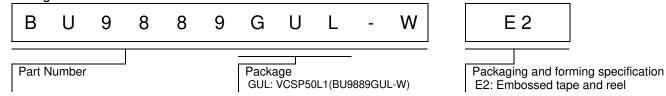
(7)Use in a strong electromagnetic field may cause malfunction, therefore, evaluate design sufficiently.

#### Status of this document

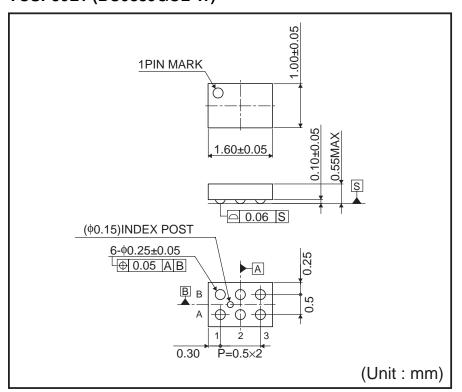
The Japanese version of this document is formal specification. A customer may use this translation version only for a reference to help reading the formal version.

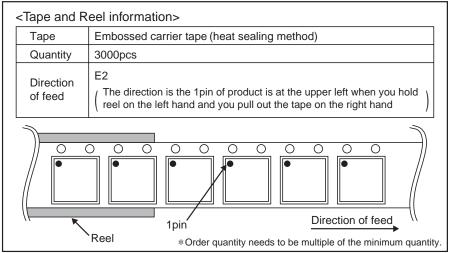
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Ordering Information

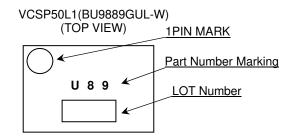


## Physical Dimension Tape and Reel Information VCSP50L1 (BU9889GUL-W)





## Marking Diagram



Revision History

Date	Revision	Changes
05.Sep.2012	001	New Release

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JÁF	PAN	USA	EU	CHINA
CLA	SSⅢ	CLACCIII	CLASS II b	CL ACCIII
CLA	SSIV	CLASSⅢ	CLASSIII	CLASSⅢ

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